

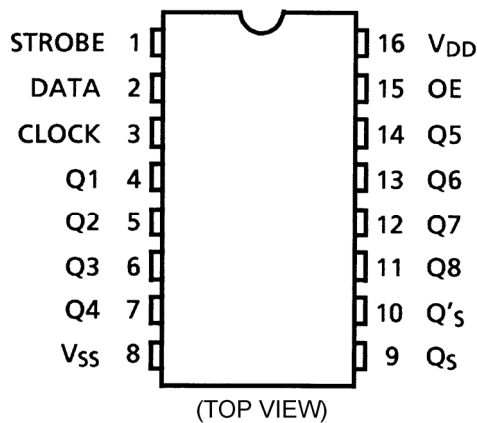
# TC4094BP, TC4094BF, TC4094BFN

## TC4094B 8-Stage Shift-and-Store Bus-Register

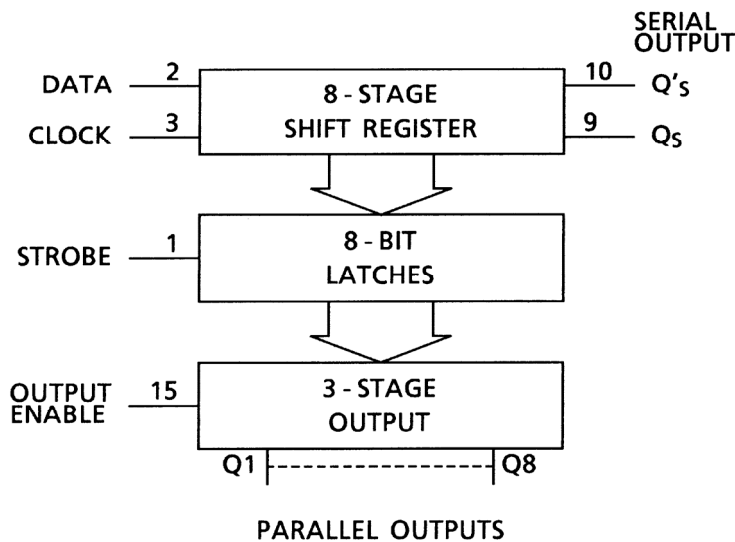
TC4094B is a SHIFT and STORE REGISTER that consists of an 8-bit shift register and an 8-bit latch. The read data in the shift register can be taken in the latch through the asynchronous STROBE input; therefore, the data transfer mode can hold output. And, since the parallel outputs is of 3-state construction, it can be directly connected to the 8-bit busline.

This register can be applied to Serial-to-parallel conversion, data receivers, etc.

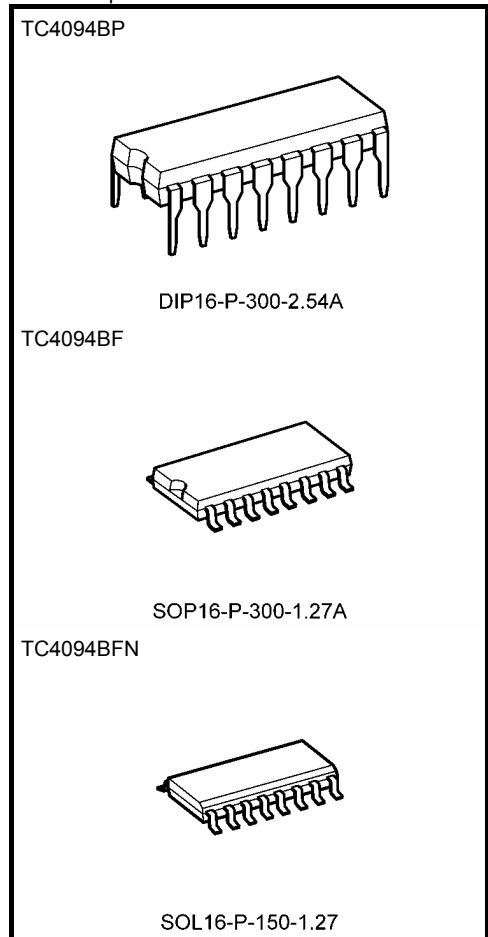
### Pin Assignment



### Block Diagram









Note: xxxFN (JEDEC SOP) is not available in Japan.



Weight	
DIP16-P-300-2.54A	: 1.00 g (typ.)
SOP16-P-300-1.27A	: 0.18 g (typ.)
SOL16-P-150-1.27	: 0.13 g (typ.)

## Truth Table

CL	OE	ST	D	PO		SO	
				Q1	Qn	Qs	Q's
	H	H	L	L	Qn - 1	Q7	NC
	H	H	H	H	Qn - 1	Q7	NC
	H	L	X	NC	NC	Q7	NC
	L	X	X	HZ	HZ	Q7	NC
	H	X	X	NC	NC	NC	Qs
	L	X	X	HZ	HZ	NC	Qs

CL = Clock

X = Don't care

OE = Output enable

NC = No change

ST = Strobe

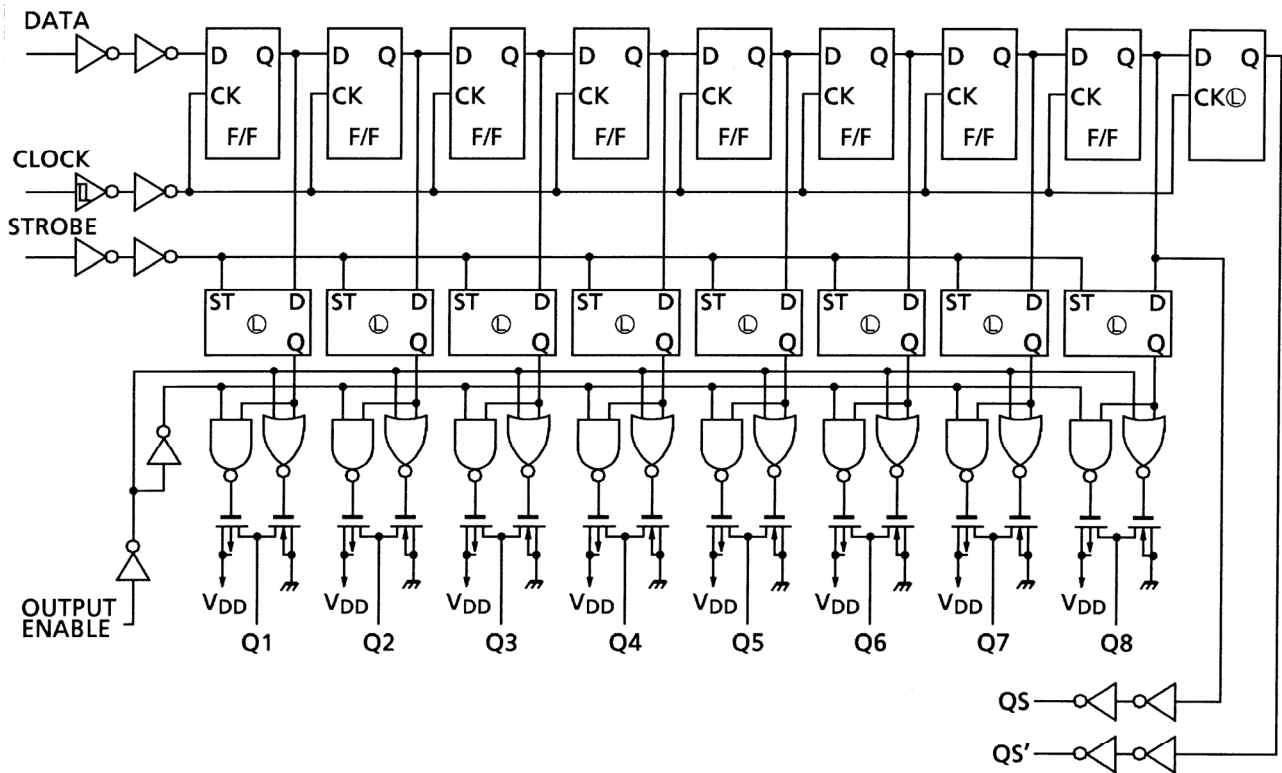
HZ = High impedance

D = Data

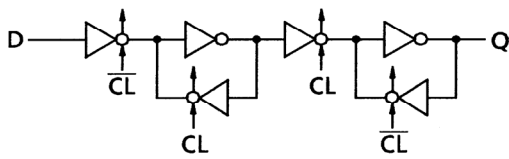
PO = Parallel outputs

SO = Serial outputs

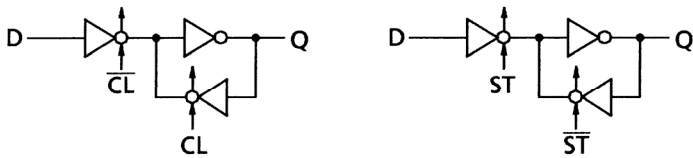
**Logic Diagram**



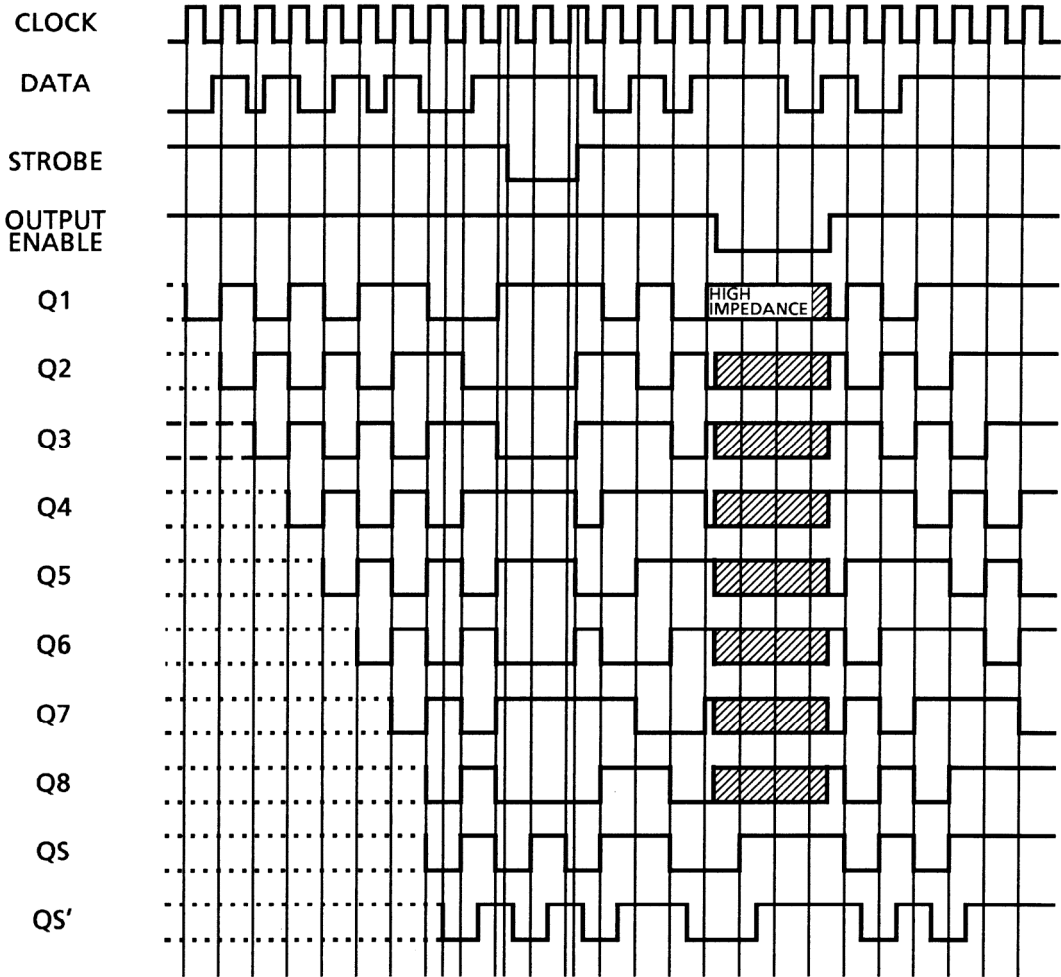
F/F



LATCH



Timing Chart



## Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
DC supply voltage	$V_{DD}$	$V_{SS} - 0.5$ to $V_{SS} + 20$	V
Input voltage	$V_{IN}$	$V_{SS} - 0.5$ to $V_{DD} + 0.5$	V
Output voltage	$V_{OUT}$	$V_{SS} - 0.5$ to $V_{DD} + 0.5$	V
DC input current	$I_{IN}$	$\pm 10$	mA
Power dissipation	$P_D$	300 (DIP)/180 (SOIC)	mW
Operating temperature range	$T_{opr}$	-40 to 85	°C
Storage temperature range	$T_{stg}$	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## Operating Ranges ( $V_{SS} = 0$ V) (Note)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
DC supply voltage	$V_{DD}$	—	3	—	18	V
Input voltage	$V_{IN}$	—	0	—	$V_{DD}$	V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .

## Static Electrical Characteristics (V<sub>SS</sub> = 0 V)

Characteristics	Sym- bol	Test Condition	V <sub>DD</sub> (V)	-40°C		25°C			85°C		Unit	
				Min	Max	Min	Typ.	Max	Min	Max		
High-level output voltage	V <sub>OH</sub>	I <sub>OUT</sub>   < 1 μA V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	4.95	—	4.95	5.00	—	4.95	—	V	
			10	9.95	—	9.95	10.00	—	9.95	—		
			15	14.95	—	14.95	15.00	—	14.95	—		
Low-level output voltage	V <sub>OL</sub>	I <sub>OUT</sub>   < 1 μA V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	—	0.05	—	0.00	0.05	—	0.05	V	
			10	—	0.05	—	0.00	0.05	—	0.05		
			15	—	0.05	—	0.00	0.05	—	0.05		
Output high current	I <sub>OH</sub>	V <sub>OH</sub> = 4.6 V V <sub>OH</sub> = 2.5 V V <sub>OH</sub> = 9.5 V V <sub>OH</sub> = 13.5 V V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	-0.61	—	-0.51	-1.0	—	-0.42	—	mA	
			5	-2.50	—	-2.10	-4.0	—	-1.70	—		
			10	-1.50	—	-1.30	-2.2	—	-1.10	—		
			15	-4.00	—	-3.40	-9.0	—	-2.80	—		
Output low current	I <sub>OL</sub>	V <sub>OL</sub> = 0.4 V V <sub>OL</sub> = 0.5 V V <sub>OL</sub> = 1.5 V V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub>	5	0.61	—	0.51	1.2	—	0.42	—	mA	
			10	1.50	—	1.30	3.2	—	1.10	—		
			15	4.00	—	3.40	12.0	—	2.80	—		
Input high voltage	V <sub>IH</sub>	V <sub>OUT</sub> = 0.5 V, 4.5 V V <sub>OUT</sub> = 1.0 V, 9.0 V V <sub>OUT</sub> = 1.5 V, 13.5 V  I <sub>OUT</sub>   < 1 μA	5	3.5	—	3.5	2.75	—	3.5	—	V	
			10	7.0	—	7.0	5.50	—	7.0	—		
			15	11.0	—	11.0	8.25	—	11.0	—		
Input low voltage	V <sub>IL</sub>	V <sub>OUT</sub> = 0.5 V, 4.5 V V <sub>OUT</sub> = 1.0 V, 9.0 V V <sub>OUT</sub> = 1.5 V, 13.5 V  I <sub>OUT</sub>   < 1 μA	5	—	1.5	—	2.25	1.5	—	1.5	V	
			10	—	3.0	—	4.50	3.0	—	3.0		
			15	—	4.0	—	6.75	4.0	—	4.0		
Input current	"H" level	I <sub>IH</sub>	V <sub>IH</sub> = 18 V	18	—	0.1	—	10 <sup>-5</sup>	0.1	—	1.0	μA
	"L" level	I <sub>IL</sub>	V <sub>IL</sub> = 0 V	18	—	-0.1	—	-10 <sup>-5</sup>	-0.1	—	-1.0	
3-state output leakage current	"H" level	I <sub>DH</sub>	V <sub>out</sub> = 18 V	18	—	0.4	—	10 <sup>-4</sup>	0.4	—	12	μA
	"L" level	I <sub>DL</sub>	V <sub>out</sub> = 0 V	18	—	-0.4	—	-10 <sup>-4</sup>	-0.4	—	-12	
Quiescent supply current	I <sub>DD</sub>	V <sub>IN</sub> = V <sub>SS</sub> , V <sub>DD</sub> (Note)	5	—	5	—	0.005	5	—	150	μA	
			10	—	10	—	0.010	10	—	300		
			15	—	20	—	0.015	20	—	600		

Note: All valid input combinations.

## Dynamic Electrical Characteristics (Ta = 25°C, VSS = 0 V, CL = 50 pF)

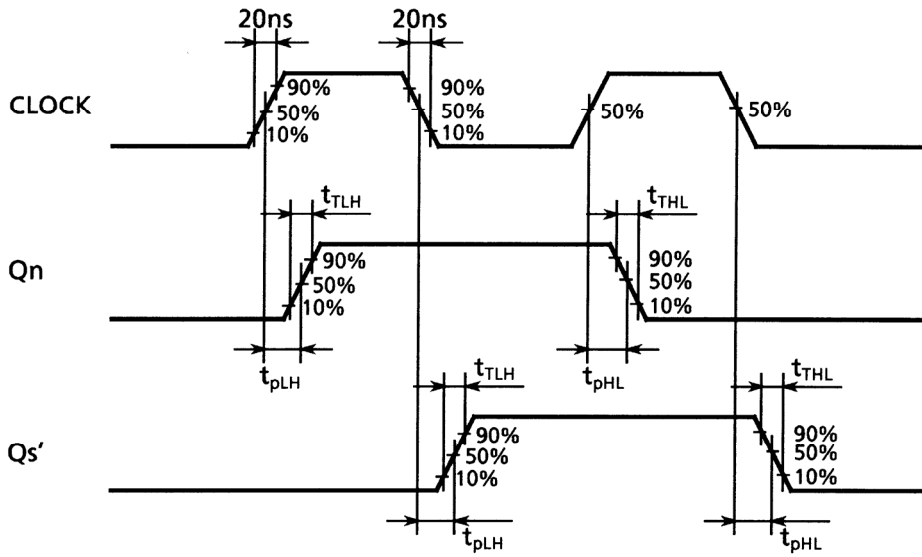
Characteristics	Symbol	Test Condition	VDD (V)	Min	Typ.	Max	Unit
Output transition time (low to high)	t <sub>TLH</sub>	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Output transition time (high to low)	t <sub>THL</sub>	—	5	—	70	200	ns
			10	—	35	100	
			15	—	30	80	
Propagation delay time (CLOCK-Q <sub>S</sub> )	t <sub>pLH</sub> t <sub>pHL</sub>	—	5	—	150	600	ns
			10	—	75	250	
			15	—	55	190	
Propagation delay time (CLOCK-Q <sub>S</sub> ' )	t <sub>pLH</sub> t <sub>pHL</sub>	—	5	—	155	460	ns
			10	—	75	220	
			15	—	55	150	
Propagation delay time (CLOCK-Q <sub>n</sub> )	t <sub>pLH</sub> t <sub>pHL</sub>	—	5	—	190	840	ns
			10	—	90	390	
			15	—	65	270	
Propagation delay time (STROBE-Q <sub>n</sub> )	t <sub>pLH</sub> t <sub>pHL</sub>	—	5	—	150	580	ns
			10	—	70	290	
			15	—	50	200	
Three state disable time (OUTPUT ENABLE-Q <sub>n</sub> )	t <sub>PHZ</sub> t <sub>PZH</sub>	R <sub>L</sub> = 1 kΩ	5	—	60	200	ns
			10	—	35	100	
			15	—	30	80	
Three state disable time (OUTPUT ENABLE-Q <sub>n</sub> )	t <sub>PLZ</sub> t <sub>PZL</sub>	R <sub>L</sub> = 1 kΩ	5	—	70	200	ns
			10	—	40	100	
			15	—	35	80	
Min clock pulse width	t <sub>w</sub>	—	5	—	45	200	ns
			10	—	20	100	
			15	—	15	80	
Min pulse width (STROBE)	t <sub>WH</sub>	—	5	—	40	200	ns
			10	—	20	80	
			15	—	15	70	
Max clock frequency	f <sub>CL</sub>	—	5	1.25	6	—	MHz
			10	2.50	12	—	
			15	3.00	16	—	
Min set-up time (DATA-CLOCK)	t <sub>SU</sub>	—	5	—	0	120	ns
			10	—	0	55	
			15	—	0	35	
Min hold time (DATA-CLOCK)	t <sub>H</sub>	—	5	—	10	40	ns
			10	—	10	20	
			15	—	5	15	
Min set-up time (CLOCK-STROBE)	t <sub>SU</sub>	—	5	—	90	200	ns
			10	—	40	100	
			15	—	30	80	

Characteristics	Symbol	Test Condition	V <sub>DD</sub> (V)	Min	Typ.	Max	Unit
Min hold time (CLOCK-STROBE)	t <sub>H</sub>	—	5	—	—	0	ns
			10	—	—	0	
			15	—	—	0	
Max clock input rise time	t <sub>rCL</sub>	—	5	No limit			μs
Max clock input fall time	t <sub>fCL</sub>		10				
			15				
Input capacitance	C <sub>IN</sub>	—		—	5	7.5	pF

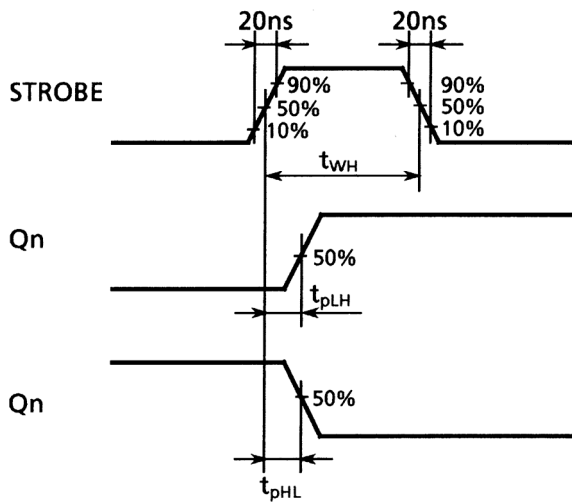


**Waveforms for Measurement of Dynamic Characteristics**

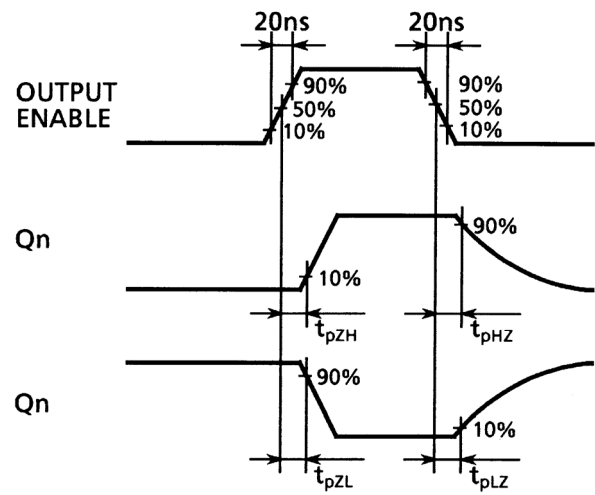
**Waveform 1**



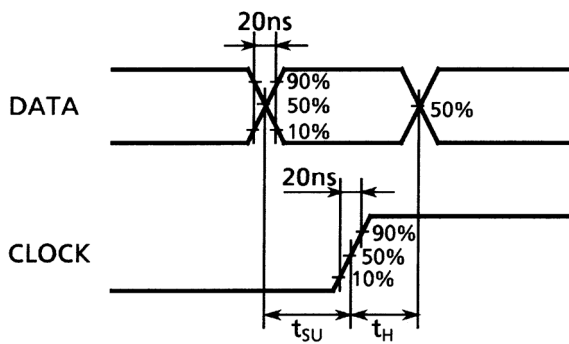
**Waveform 2**



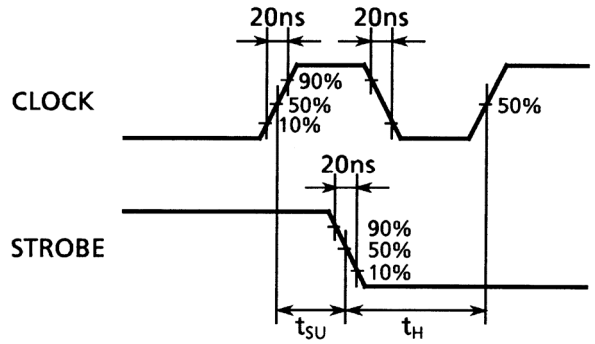
**Waveform 3**



**Waveform 4**



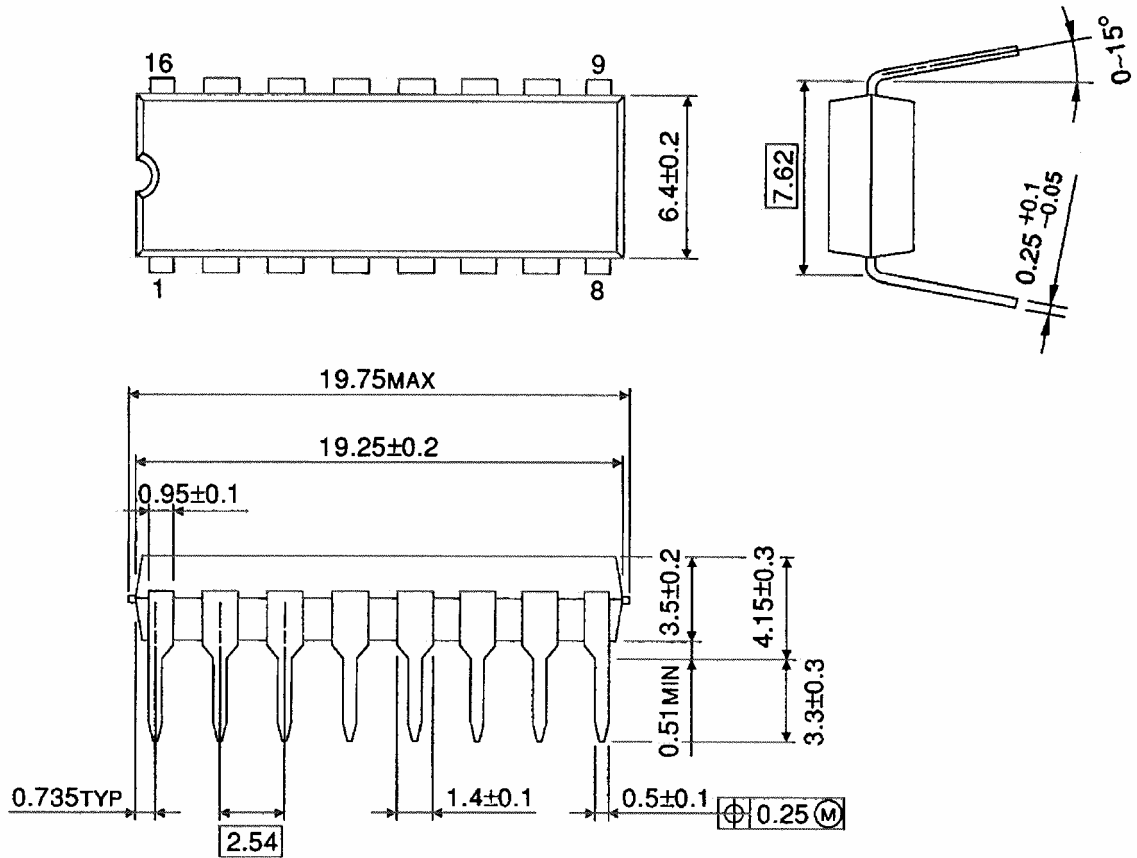
**Waveform 5**



**Package Dimensions**

DIP16-P-300-2.54A

Unit : mm

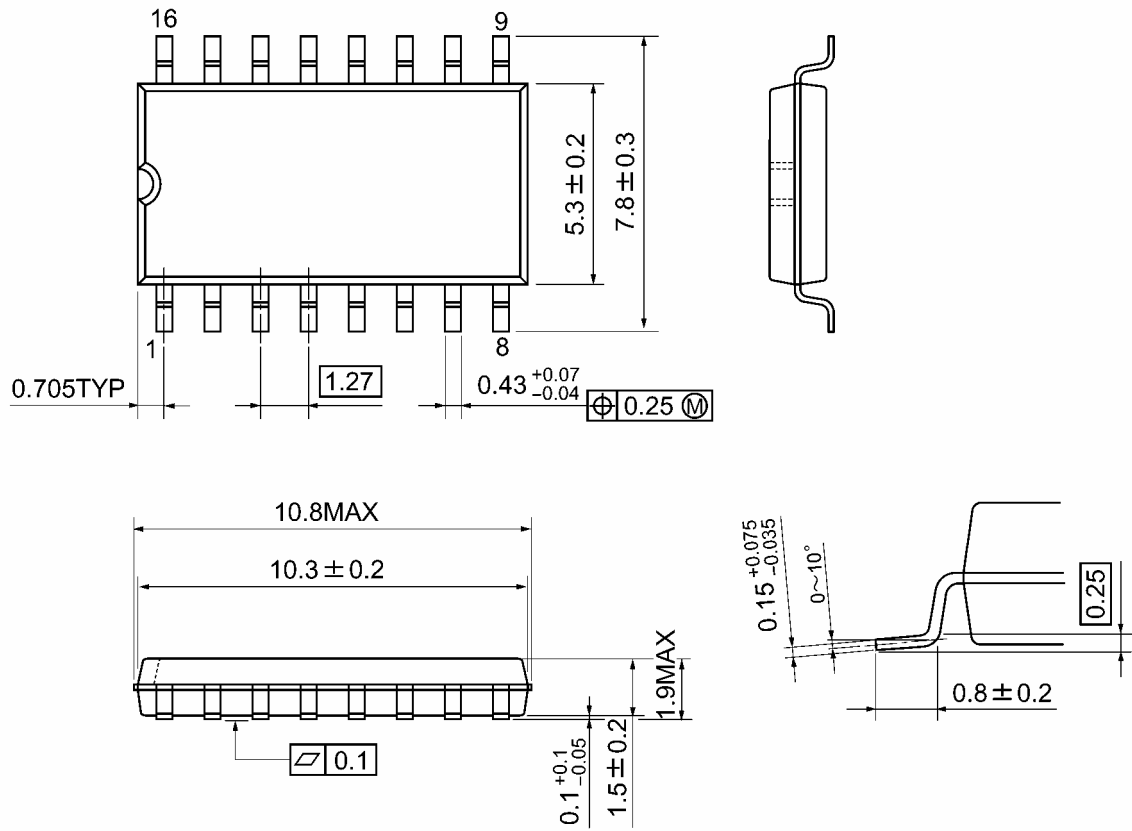


Weight: 1.00 g (typ.)

## Package Dimensions

SOP16-P-300-1.27A

Unit: mm

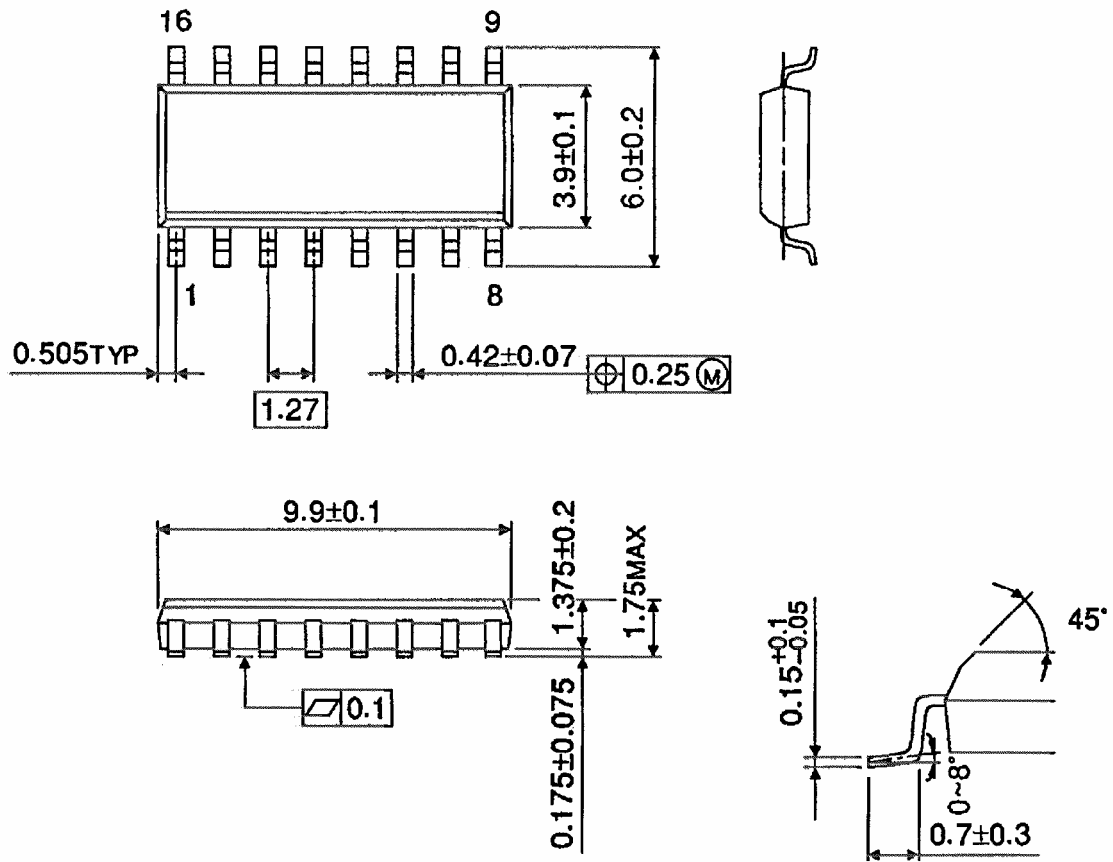


Weight: 0.18 g (typ.)

Package Dimensions (Note)

SOL16-P-150-1.27

Unit : mm



Note: This package is not available in Japan.

Weight: 0.13 g (typ.)

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20070701-EN GENERAL

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